

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/577,014	SANO, HISASHI	
		Examiner	Art Unit	Page 1 of 1
		RANDOLPH CHU	2624	

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*	B	US-7,565,044	07-2009	Akahoshi et al.	385/16
	C	US-			
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	E	US-			
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	M	US-			

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